

5G Verification Source 10 GHz - SN: 2002

February 20, 2025

DASY Report

Measurement Report for 5G Verification Source 10 GHz, UID 0 --, Channel 10000.0 (10000.0 MHz)

Device Under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
5G Verification Source 10 GHz	100.0 x 100.0 x 100.0	SN: 2002	-

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G --	10.0 mm	Validation band	CW, 0--	10000.0,10000	1.0

Hardware Setup

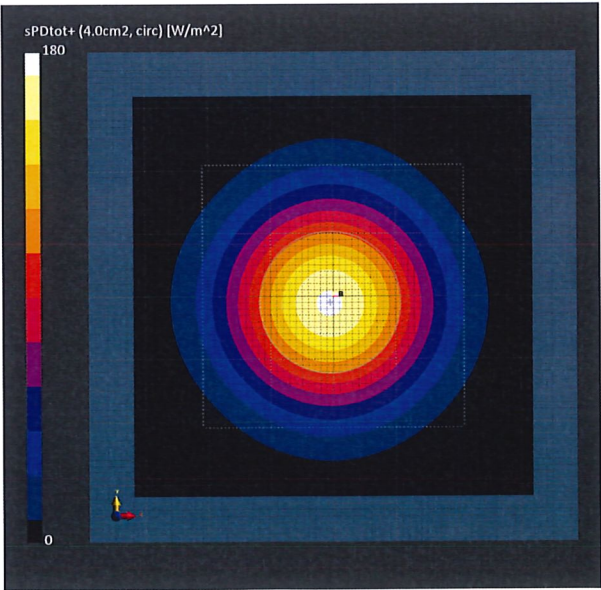
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave Phantom --	Air --	EUmmWV3 -- SN9374_F1--55GHz, 2024-08-28	DAE4ip -- SN1602, 2024-11-06

Scans Setup

Sensor Surface [mm]	10.0
MAIA	MAIA not used

Measurement Results

Scan Type	5G Scan
Date	2025-02-20
Avg. Area [cm ²]	4.00
Avg. Type	Circular Averaging
psPDn+ [W/m ²]	167
psPDtot+ [W/m ²]	168
psPDmod+ [W/m ²]	172
Max(Sn) [W/m ²]	231
Max(Stot) [W/m ²]	232
Max(Stot) [W/m ²]	232
E _{max} [V/m]	286
Power Drift [dB]	0.0



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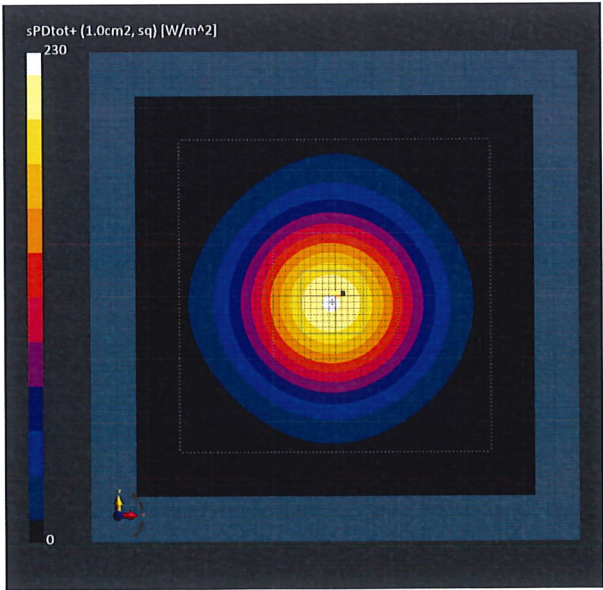
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
mmWave Phantom --	Air --	EUmmWV3 -- SN9374_F1--55GHz, 2024-08-28	DAE4ip -- SN1602, 2024-11-06

Scans Setup

Sensor Surface [mm]	10.0
MAIA	MAIA not used

Measurement Results

Scan Type	5G Scan
Date	2025-02-20
Avg. Area [cm ²]	1.00
Avg. Type	Square Averaging
psPDn+ [W/m ²]	212
psPDtot+ [W/m ²]	213
psPDmod+ [W/m ²]	215
Max(Sn) [W/m ²]	231
Max(Stot) [W/m ²]	232
Max(Stot) [W/m ²]	232
E _{max} [V/m]	286
Power Drift [dB]	0.0



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5G Verification Source 10 GHz	100.0 x 100.0 x 100.0	SN: 2002	–

Exposure Conditions

Phantom Section	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor
5G –	10.0 mm	Validation band	CW, 0--	10000.0,10000	1.0

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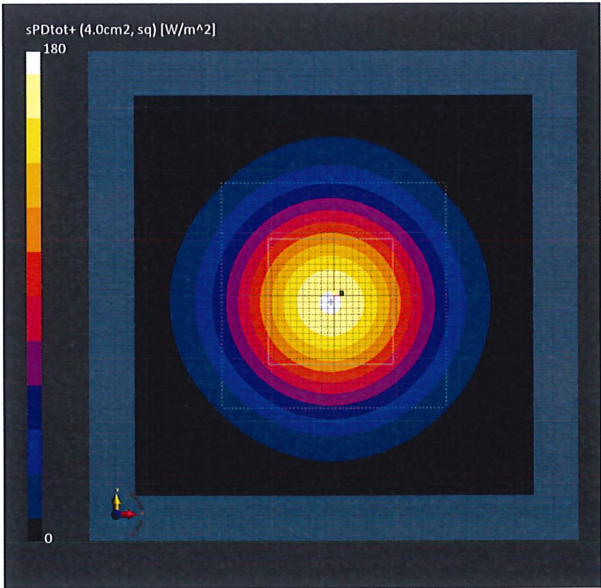
Phantom	Medium	Probe, Calibration Date	DAE, Calibration Date
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Scans Setup

Sensor Surface [mm]	10.0
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E _{max} [V/m]	286
Power Drift [dB]	0.0



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s p e a g

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IMPORTANT NOTICE

USAGE OF THE DAE4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention must be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **Sporton**
Shenzhen

Certificate No: **DAE4-1210_Dec24**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BM - SN: 1210**

Calibration procedure(s) **QA CAL-06.v30**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **December 17, 2024**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	27-Aug-24 (No:40547)	Aug-25
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	23-Jan-24 (in house check)	In house check: Jan-25
Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-24 (in house check)	In house check: Jan-25

Calibrated by: **Name**
Adrian Gehring **Function**
Laboratory Technician

Approved by: **Sven Kühn** **Technical Manager**

Signature

Issued: December 17, 2024

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of
Schmid & Partner
Engineering AG
 Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
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 Swiss Calibration Service

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Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V , full range = -100...+300 mV

Low Range: 1LSB = 61nV , full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.361 $\pm$ 0.02% (k=2)	405.069 $\pm$ 0.02% (k=2)	404.501 $\pm$ 0.02% (k=2)
Low Range	3.98719 $\pm$ 1.50% (k=2)	3.97137 $\pm$ 1.50% (k=2)	3.98870 $\pm$ 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	338.5 ° $\pm$ 1 °
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Appendix (Additional assessments outside the scope of SCS0108)**1. DC Voltage Linearity**

High Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	199994.38	-0.85	-0.00
Channel X	+ Input	20003.04	0.77	0.00
Channel X	- Input	-20000.48	2.06	-0.01
Channel Y	+ Input	199993.56	-1.79	-0.00
Channel Y	+ Input	19999.19	-2.97	-0.01
Channel Y	- Input	-20003.49	-0.77	0.00
Channel Z	+ Input	199994.38	-1.24	-0.00
Channel Z	+ Input	20002.38	0.29	0.00
Channel Z	- Input	-20002.87	-0.25	0.00

Low Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	2000.83	-0.00	-0.00
Channel X	+ Input	202.06	0.87	0.43
Channel X	- Input	-197.99	0.56	-0.28
Channel Y	+ Input	2001.11	0.20	0.01
Channel Y	+ Input	200.45	-0.67	-0.33
Channel Y	- Input	-199.16	-0.59	0.30
Channel Z	+ Input	2000.63	-0.38	-0.02
Channel Z	+ Input	200.31	-0.87	-0.43
Channel Z	- Input	-199.81	-1.26	0.63

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	24.50	22.85
	- 200	-21.89	-23.06
Channel Y	200	-10.26	-10.73
	- 200	9.95	9.50
Channel Z	200	-15.68	-15.70
	- 200	14.22	14.02

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	3.34	-4.28
Channel Y	200	8.49	-	4.14
Channel Z	200	9.69	6.35	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15722	16119
Channel Y	16245	15971
Channel Z	15942	17256

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	0.73	-0.53	1.82	0.48
Channel Y	-0.31	-1.64	0.66	0.36
Channel Z	-0.77	-1.79	0.89	0.39

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9